

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/686,335	SCHUCHARDT, JONATHAN L.	
Examiner		Art Unit		Page 1 of 1
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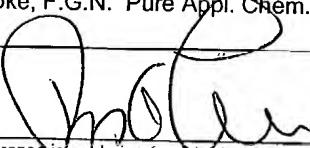
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**NON-PATENT DOCUMENTS**

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*	U	Mehta et al. J. Am. Chem. Soc. 1986, 108, 3443.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

*November 24, 2004*